ATTN: BOX DD PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

DEC 1 2 2002

In Re the Application of:

McCall, Catherine A. Babu, Uma Mahesh Radecki, Steven V...

Serial No.: 10/038,519

Filed: January 3, 2002

Atty. File No.: SC-1-C2

For: "DETECTION OF ALLERGEN-

SPECIFIC IgE"

Examiner:

Group Art Unit: 1641

TECH CENTER 1600/2900

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

CERTIFICATE OF MAILING

I HEREBY CERTIFY THAT THIS CORRESPONDENCE IS BEING DEPOSITED WITH THE UNITED STATES POSTAL SERVICE AS FIRST CLASS MAIL ADDRESSED TO BOX DD, COMMISSIONER FOR PATENTS, WASHINGTON, DC 20231, THIS 2 DAY OF DECEMBER 2002.

HESKA CORPORATION

Box DD Commissioner for Patents Washington, D.C. 20231

Dear Sir:

Pursuant to Applicants' duty of disclosure under 37 CFR § 1.56, Applicants hereby submit this Supplemental Information Disclosure Statement with a copy of the document identified on the enclosed PTO Form-1449, although Applicants do not admit that such document is considered to be material to patentability as defined in 37 CFR § 1.56(b). Each item of information included in this Supplemental Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application on November 6, 2002, and therefore not more than three months prior to the filing of the instant Supplemental Information Disclosure Statement.

Respectfully submitted,

Dated: December 2, 2002

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE **INFORMATION DISCLOSURE** STATEMENT BY APPLICANT

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ATTY. DOCKET NO. SC-1-C2

SERIAL NO. 10/038,519

APPLICANT Catherine A. McCall; Uma Mahesh Babu; Steven V. Radecki

FILING DATE January 3, 2002

GROUP 1641

& TRACE

U.S. PATENT DOCUMENTS												
EXAM. INITIAL		DOCUMENT NUMBER	ISSUE DATE	PATENTEE	CLS	SUB-CLS	FILE DATE					
							3.					

	FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATIONS											
EXAM. INITIAL	DOCUMENT NUMBER		PUBL. DATE	COUNTRY	CLS	SUB-CLS	TRANS					
	B1	DE 197 21 151 A1	26 November 1998	Germany								
	B2	DE 38 20 556 A1	21 December 1989	Germany								
	В3	EP 0 556 745 A1	25 August 1993	Europe								
	В4	WO 94/29696	22 December 1994	PCT								
	B5	WO 97/20859	12 June 1997	РСТ								

EXAMINER

DATE CONSIDERED

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant

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